

### STL17N3LLH6

# N-channel 30 V, 0.0038 Ω typ., 17 A STripFET™ VI DeepGATE™ Power MOSFET in a PowerFLAT™ 3.3 x 3.3 package

Datasheet - production data

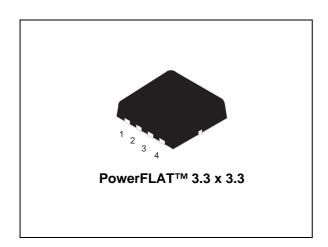
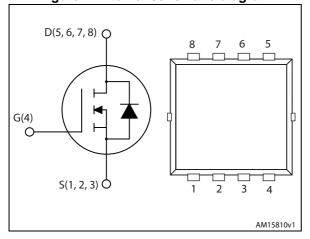


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STL17N3LLH6	30 V	$0.0045~\Omega$	17 A <sup>(1)</sup>

- 1. The value is rated according R<sub>thj-pcb.</sub>
- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses
- · Very low switching gate charge

### **Applications**

· Switching applications

### **Description**

This device is an N-channel Power MOSFET developed using the  $6^{th}$  generation of STripFET<sup>TM</sup> DeepGATE<sup>TM</sup> technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL17N3LLH6	17N3L	PowerFLAT™ 3.3 x 3.3	Tape and reel

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STL17N3LLH6 Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	30	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	17	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 100 °C	11	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	68	Α
P <sub>TOT</sub> (3)	Total dissipation at T <sub>C</sub> = 25 °C	50	W
P <sub>TOT</sub> (1)	Total dissipation at T <sub>pcb</sub> = 25 °C	2	W
	Derating factor	0.03	W/°C
T <sub>J</sub>	Operating junction temperature	-55 to 150	°C
T <sub>stg</sub>	Storage temperature	-55 (0 150	°C

<sup>1.</sup> The value is rated according  $R_{thj\text{-pcb}}$ .

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub> (2)	Thermal resistance junction-case	2.5	°C/W
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-pcb	42.8	°C/W
R <sub>thj-pcb</sub> <sup>(2)</sup>	Thermal resistance junction-pcb	63.5	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1inch², 2oz Cu, t < 10 sec.

<sup>2.</sup> Pulse width limited by safe operating area.

<sup>3.</sup> The value is rated according  $R_{thj-c}$ .

<sup>2.</sup> Steady state.

Electrical characteristics STL17N3LLH6

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	30			V
	Zero gate voltage drain	$V_{GS} = 0, V_{DS} = 30 V$			1	μΑ
I <sub>DSS</sub>	current	V <sub>GS</sub> = 0, V <sub>DS</sub> = 30 V, T <sub>C</sub> =125 °C			10	μΑ
I <sub>GSS</sub>	Gate body leakage current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 8.5 \text{ A}$		0.0038 0.0057	0.0045 0.0073	Ω

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	1690	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 24 V, f=1 MHz,	-	290	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> =0	-	176	-	pF
Qg	Total gate charge	V <sub>DD</sub> = 24 V, I <sub>D</sub> = 17 A V <sub>GS</sub> = 4.5 V (see Figure 14)	-	17	-	nC
Q <sub>gs</sub>	Gate-source charge		-	8	-	nC
Q <sub>gd</sub>	Gate-drain charge		-	6	-	nC
R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	-	1.7	-	Ω

#### Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD}$ = 24 V, $I_{D}$ = 8.5 A, $R_{G}$ = 4.7 $\Omega$ , $V_{GS}$ = 10 V (see Figure 13)	-	9.5	-	ns
t <sub>r</sub>	Rise time		-	30	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	37	-	ns
t <sub>f</sub>	Fall time		-	12	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current		-		17	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		68	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 17 A, V <sub>GS</sub> = 0	-		1.1	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 17 A,	-	24		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/μs,	-	16.8		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> = 24 V	-	1.4		Α

<sup>1.</sup> Pulse width limited by safe operating area.

<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%.

Electrical characteristics STL17N3LLH6

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

100 AM15811v1

100 Toleran Tip-150°C
Tc=25°C
Single pulse

10

V<sub>DS</sub>(V)

Figure 3. Thermal impedance

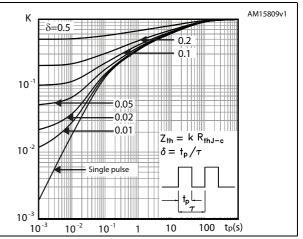


Figure 4. Output characteristics

0.1

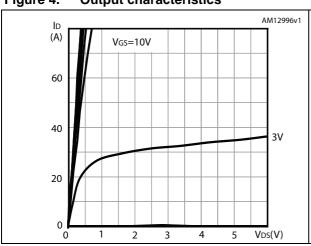


Figure 5. Transfer characteristics

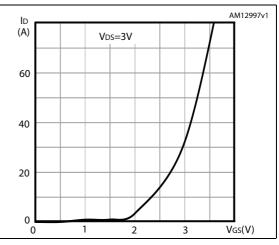


Figure 6. Normalized B<sub>VDSS</sub> vs temperature

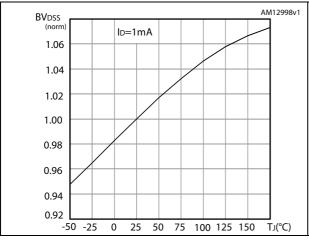
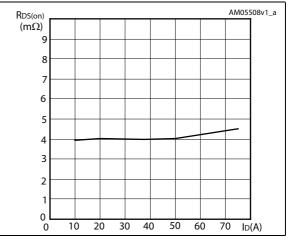


Figure 7. Static drain-source on-resistance



AM13000v1 AM13001v1 Vgs ID=17A (V) (pF) V<sub>DD</sub>=24V 12 2100 10 Ciss 1600 8 1100 4 600 Coss 2 Crss 100 10 20 30 35 Qg(nC) 10 20 V<sub>DS</sub>(V) 15 25

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on-resistance vs vs temperature temperature

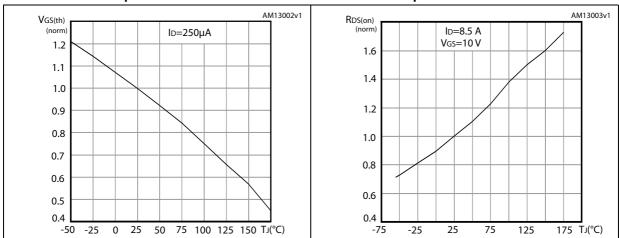
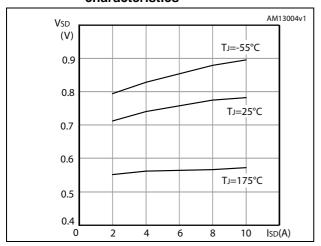


Figure 12. Source-drain diode forward characteristics



Test circuits STL17N3LLH6

### 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

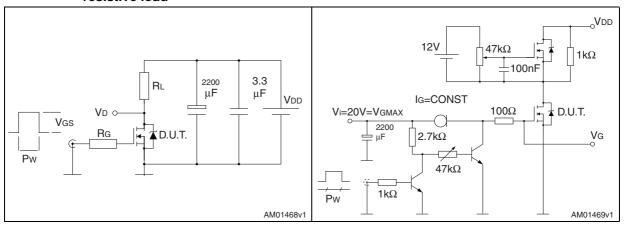


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

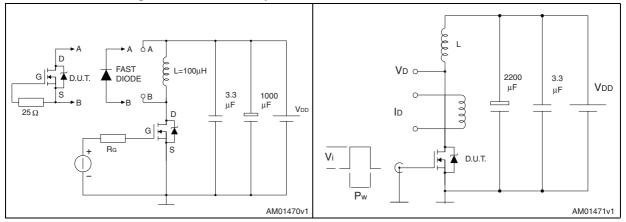
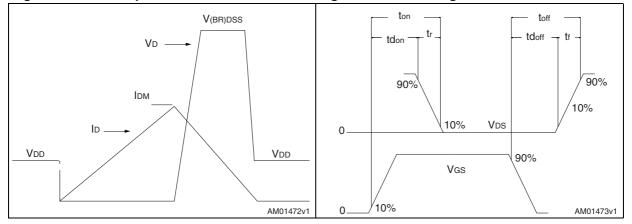


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



Table 8. PowerFLAT™ 3.3 x 3.3 mechanical data

Dim.		mm	
Dilli.	Min.	Тур.	Max.
А	0.70	0.80	0.90
b	0.25	0.30	0.39
С	0.14	0.15	0.20
D	3.10	3.30	3.50
D1	3.05	3.15	3.25
D2	2.15	2.25	2.35
е	0.55	0.65	0.75
E	3.10	3.30	3.50
E1	2.90	3.00	3.10
E2	1.60	1.70	1.80
Н	0.25	0.40	0.55
K	0.65	0.75	0.85
L	0.30	0.45	0.60
L1	0.05	0.15	0.25
L2			0.15
θ	8°	10°	12°

-D2-**BOTTOM VIEW** SIDE VIEW - D1 -**TOP VIEW -**∟2  $\Box$ - D -8465286\_A

Figure 19. PowerFLAT™ 3.3 x 3.3 drawing

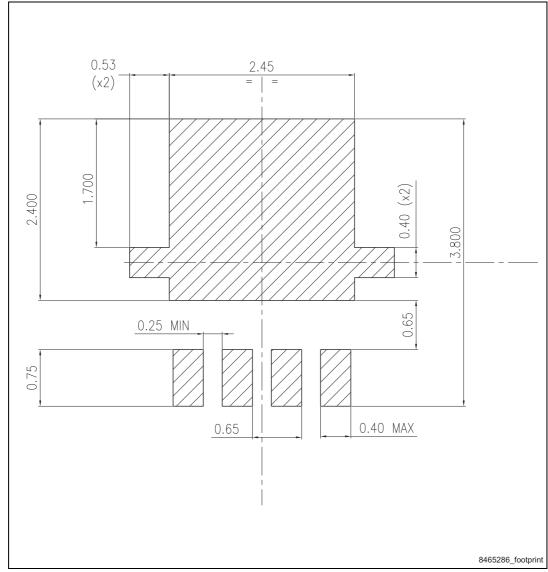


Figure 20. PowerFLAT™ 3.3 x 3.3 recommended footprint

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STL17N3LLH6 Revision history

# 5 Revision history

**Table 9. Document revision history** 

Date	Revision	Changes
24-Mar-2009	1	First release.
06-Jul-2010	2	Updated Table 4: On/off states.
10-Nov-2010	3	Document status promoted from preliminary data to datasheet.
17-Jun-2013	4	<ul> <li>Updated: Figure 1, silhouette in cover page and Section 4:</li> <li>Package mechanical data</li> <li>Minor text changes</li> </ul>

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